

Search Notes

Application/Control No.

10/771,602

Examiner

HIEU T. VO

Applicant(s)/Patent under
Reexamination

LANG ET AL.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
701	102 103 114 115	3/19/2006	VH
73	118.1	3/19/2006	VH
73	118.2	3/19/2006	VH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
All of above		3/19/2006	VH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/19/2006	VH